

Search Notes

Application/Control No.

10/807,432

Examiner

Nam Huynh

Applicant(s)/Patent under
Reexamination

YOSHIDA ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
A further evaluation of previously cited references was conducted.	10/25/2007	NTH